

Notice of References Cited

Application/Control No.

09/824,580

Applicant(s)/Patent Under
Reexamination
RUTLEDGE ET AL.

Examiner

Md S Elahee

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0137503	09-2002	Roderique, Benjamin O.	455/420
	B	US-6,009,444	12-1999	Chen, Xixian	715/535
	C	US-2002/0136371	09-2002	Bozorgui-Nesbat, Saied	379/93.18
	D	US-2002/0009184	01-2002	SHNIER, J. MITCHELL	379/142.01
	E	US-6,216,016	04-2001	Cronin, Gerard T.	455/567
	F	US-5,029,198	07-1991	Walpole et al.	379/88.23
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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